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INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE

Specification for radio disturbance and immunity measuring apparatus and methods –

Part 4-5:

Uncertainties, statistics and limit modelling –

Conditions for the use of alternative test methods

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

SPECIFICATION FOR RADIO DISTURBANCE AND IMMUNITY MEASURING APPARATUS AND METHODS –

Part 4-5: Uncertainties, statistics and limit modelling – Conditions for the use of alternative test methods

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CISPR 16-4-5, which is a technical report, has been prepared by CISPR subcommittee A: Radio-interference measurements and statistical methods.

The text of this technical report is based on the following documents:

Enquiry draft	Report on voting
CISPR/A/665/DTR	CISPR/A/685/RVC

Full information on the voting for the approval of this technical report can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts of the CISPR 16-4 series, published under the general title *Specification for radio disturbance and immunity measuring apparatus and methods – Part 4: Uncertainties, statistics and limit modelling*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the maintenance result date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

A bilingual version of this publication may be issued at a later date.

SPECIFICATION FOR RADIO DISTURBANCE AND IMMUNITY MEASURING APPARATUS AND METHODS –

Part 4-5: Uncertainties, statistics and limit modelling – Conditions for the use of alternative test methods

1 Scope

This part of CISPR 16-4 specifies a method to enable product committees to develop limits for alternative test methods, using conversions from established limits. This method is generally applicable for all kinds of disturbance measurements, but focuses on radiated disturbance measurements (i.e. field strength), for which several alternative methods are presently specified. These limits development methods are intended for use by product committees and other groups responsible for defining emissions limits in situations where it is decided to use alternative test methods and the associated limits in product standards.

2 Normative references

IEC 60050-161, *International Electrotechnical Vocabulary (IEV) – Chapter 161: Electromagnetic compatibility*

CISPR 16-4-1:2003, *Specification for radio disturbance and immunity measuring apparatus and methods – Part 4-1: Uncertainties, statistics and limit modelling – Uncertainty in standardized EMC tests*

CISPR 16-4-2:2003, *Specification for radio disturbance and immunity measuring apparatus and methods – Part 4-2: Uncertainties, statistics and limit modelling – Uncertainty in EMC measurements*